

Notice of References Cited	Application/Control No. 10/670,310	Applicant(s)/Patent Under Reexamination ISHIKAWA, AKIRA	
	Examiner Lex Malsawma	Art Unit 2825	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,049,514	09-1991	Mori, Seiichi	438/301
	B	US-5,079,617	01-1992	Yoneda, Masahiro	257/755
	C	US-5,413,961	05-1995	Kim, Jae K.	438/639
	D	US-5,432,108	07-1995	Lee, Who Y.	438/157
	E	US-5,445,987	08-1995	Kuroda et al.	438/257
	F	US-5,473,184	12-1995	Murai, Ichiro	257/382
	G	US-5,687,113	11-1997	Papadas et al.	365/185.01
	H	US-5,767,006	06-1998	Lee, Jian-Huei	438/597
	I	US-6,180,502 B1	01-2001	Liang, Chunlin	438/595
	J	US-6,297,093 B1	10-2001	Borel et al.	438/257
	K	US-6,495,406 B1	12-2002	Honeycutt, Jeffrey W.	438/197
	L	US-6,613,666 B2	09-2003	Ma, Shawming	438/637
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 63275181 A	11-1988	Japan	OOKA, HIDEYUKI	H01L 29/78
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.